

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10577919	LEE ET AL.
Examiner	Art Unit	
	MARCOS BATISTA	2617

SEARCHED

Class	Subclass	Date	Examiner
370	335	5/6/2008	mb
370	342	5/6/2008	mb

SEARCH NOTES

Search Notes	Date	Examiner
Consulted with TA - Yogesh Aggarwal	5/6/2008	mb
Consulted with Lun-Yi Lao	5/6/2008	mb
Inventor's Name Seach	5/6/2008	mb
Consulted with Rafael Perez Gutierrez	5/4/2009	mb
East Search	11/5/2008	mb

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner